

Applica	tion/Control No.	Applicant(s)/Patent un Reexamination	nder
10/510,	480	IIO, MASATOSHI	
Examin	er	Art Unit	
Alfred E	Basichas	3749	

F					
SEARCHED					
Class	Subclass	Date	Examiner		
431	6,7,11				
	326,328				
429	20,26,24				
422	198	2/26/2007	AB		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		— —)
	DATE	EXMR
CONDUCTED INVENTOR SEARCH		
SEE ATTACHED EAST SEARCH HISTORY	2/26/2007	АВ